

**Search Notes**

Application/Control No.

10/734,162

Examiner

Matthew Landau

Applicant(s)/Patent under  
Reexamination

PARK ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	64, 66, 70, 75	12/14/05	mm

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EST Search (printout included)	12/14/05	mm